
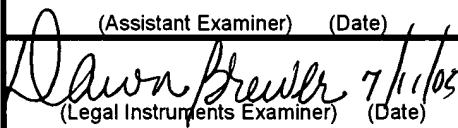
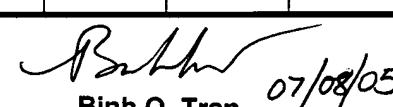


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/790,783	SAITO ET AL.	
	Examiner	Art Unit	
	BINH Q. TRAN	3748	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
60		295		60	297	311			
INTERNATIONAL CLASSIFICATION									
F01N		3100							
			/						
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			/						
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 (Assistant Examiner) (Date)		 Binh Q. Tran Patent Examiner Technology Center 3700 (Primary Examiner) (Date)		Total Claims Allowed: 12	
				O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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